Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | KAKUTA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-2002/0127367 A1	09-2002	Shibata, Michihiro	428/64.4
	В	US-6,500,511 B1	12-2002	Ooki et al.	428/64.1
	С	US-6,815,035 B2	11-2004	Bennett et al.	428/65.1
	D	US-2004/0170119 A1	09-2004	Watanabe, Hidetoshi	369/286
	E	US-6,087,067 A	07-2000	Kato et al.	430/270.13
	F	US-2003/0184891 A1	10-2003	Hosoi et al.	359/883
	G	US-6,599,602 B2	07-2003	Bennett et al.	428/64.1
	Н	US-5,219,708 A	06-1993	Hirata et al.	430/270.11
	1	US-2004/0038057 A1	02-2004	Katoh et al.	428/500
	J	US-5,936,934 A	08-1999	Kuribayashi et al.	369/286
	к	US-6,500,295 B1	12-2002	Kubota, Yuichi	156/269
	L	US-6,037,099 A	03-2000	Oogo et al.	430/270.11
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2	JP02002088325A	03-2002	Japan	Nagoya et al	
	0	JP02002241711A	08-2002	Japan	Dobashi et al	
	Р	DERWENT 2002-503249	03-2002	Japan	Hitachi CHEM Co LTD	
	Q	JP403229783A	10-1991	Japan	Nakayama	
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	· ;

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.